

## N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	200					
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	0.85				
Q <sub>g</sub> (Max.) (nC)	13					
Q <sub>gs</sub> (nC)	3.0					
Q <sub>gd</sub> (nC)	7.9					
Configuration	Single					

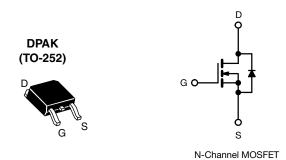
#### **FEATURES**

- TrenchFET® Power MOSFET
- 175 °C Junction Temperature
- **PWM Optimized**
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC



#### **APPLICATIONS**

· Primary Side Switch



PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	200	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I-	5.0	А	
Continuous Diain Guirent	VGS at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	4.0		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	20		
Linear Derating Factor				0.33	W/°C	
Linear Derating Factor (PCB Mount) <sup>e</sup>				0.020	7 W/C	
Single Pulse Avalanche Energy b			E <sub>AS</sub>	161	mJ	
Repetitive Avalanche Current a			I <sub>AR</sub>	4.8	А	
Repetitive Avalanche Energy a			E <sub>AR</sub>	4.2	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		Б	42	w	
Maximum Power Dissipation (PCB mount) <sup>e</sup>	T <sub>A</sub> = 25 °C		P <sub>D</sub> 2.5		vv	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering Recommendations (Peak temperature) d	for 10 s		-	260	→ °C	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=50~V$ , starting  $T_J=25~^{\circ}C$ , L=14~mH,  $R_g=25~\Omega$ ,  $I_{AS}=4.8~A$  (see fig. 12). c.  $I_{SD}\leq5.2~A$ ,  $dI/dt\leq95~A/\mu s$ ,  $V_{DD}\leq V_{DS}$ ,  $T_J\leq150~^{\circ}C$ .

- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

服务热线:400-655-8788

1



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	110	
Maximum Junction-to-Ambient (PCB mount) <sup>a</sup>	R <sub>thJA</sub>	-	-	50	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	3.0	

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				l	l .		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.29	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zawa Cata Waltana Dunin Commant	I <sub>DSS</sub>	V <sub>DS</sub> =	V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 160 V	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.9 A <sup>b</sup>	-	0.85	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 2.9 A <sup>b</sup>		1.7	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		=.	185	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 25 \text{ V},$	=	100	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	.0 MHz, see fig. 5	-	30	-	
Total Gate Charge	Qg			-	-	13.0	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$	$I_D = 4.8 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 b	=	-	3.0	nC
Gate-Drain Charge	Q <sub>gd</sub>		occ lig. o and ro	-	-	7.9	
Turn-On Delay Time	t <sub>d(on)</sub>		V <sub>DD</sub> = 100 V, I <sub>D</sub> = 4.8 A,		7.2	-	ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =			22	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_G = 18 \Omega$ , $R_D = 20 \Omega$ , see fig. 10 b		-	19	-	
Fall Time	t <sub>f</sub>		1		13	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nЦ
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.8	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	19	_ ^
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25  ^{\circ}\text{C},  I_S = 4.8  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 4.8 A, dl/dt = 100 A/µs b		-	150	300	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.91	1.8	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	ırn-on time is negligible (turn	on is dor	ninated b	v Ls and	L <sub>D</sub> )

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu s$ ; duty cycle  $\leq$  2 %.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

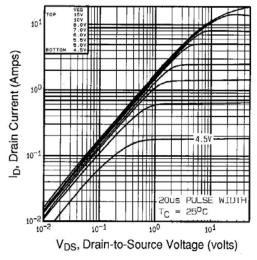


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

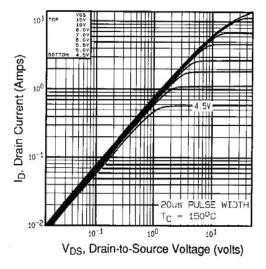


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

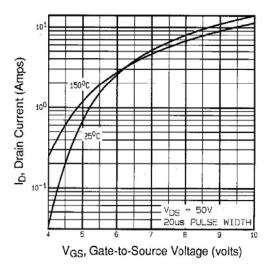


Fig. 3 - Typical Transfer Characteristics

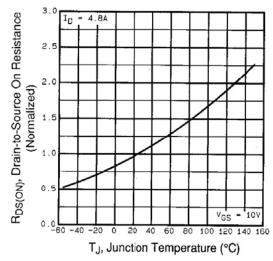


Fig. 4 - Normalized On-Resistance vs. Temperature



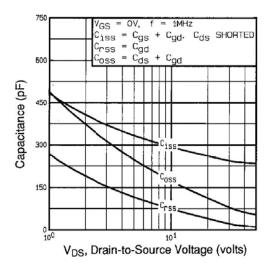


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

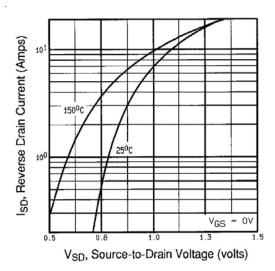


Fig. 7 - Typical Source-Drain Diode Forward Voltage

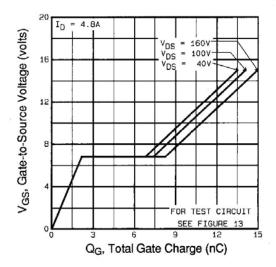


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

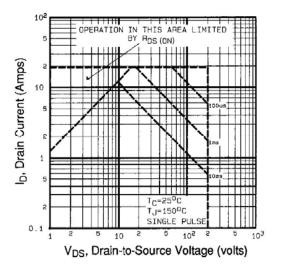


Fig. 8 - Maximum Safe Operating Area



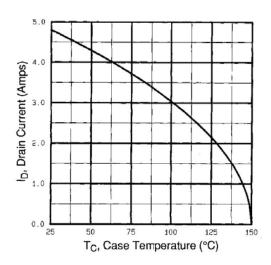


Fig. 9 - Maximum Drain Current vs. Case Temperature

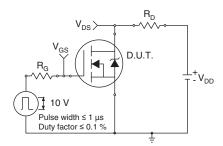


Fig. 10a - Switching Time Test Circuit

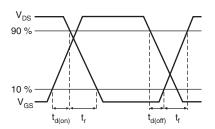


Fig. 10b - Switching Time Waveforms

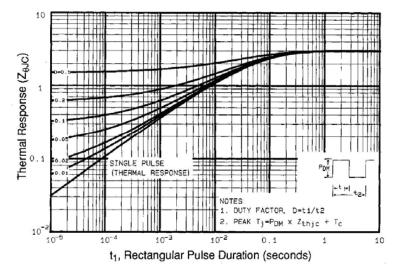


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



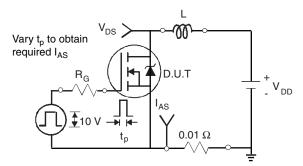


Fig. 12a - Unclamped Inductive Test Circuit

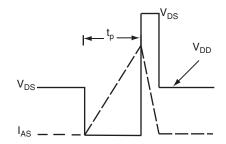


Fig. 12b - Unclamped Inductive Waveforms

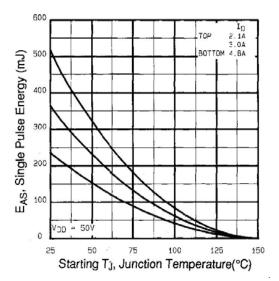


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

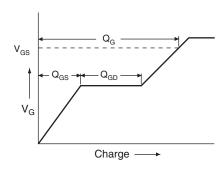


Fig. 13a - Basic Gate Charge Waveform

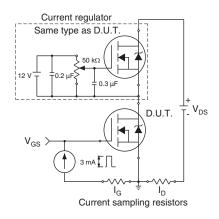
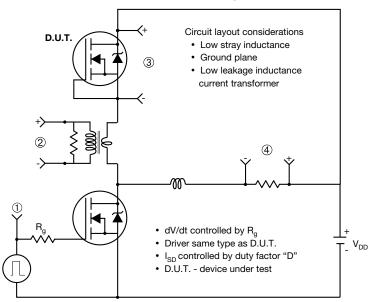


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



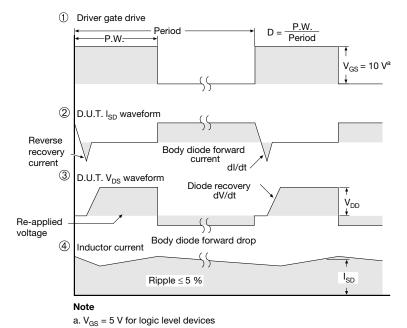
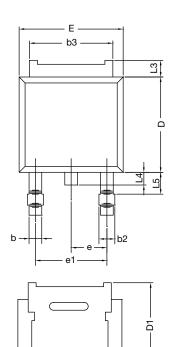
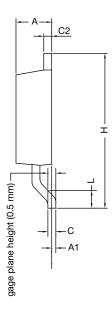


Fig. 14 - For N-Channel



### **TO-252AA Case Outline**





	MILLIN	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	4.10	-	0.161	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090	BSC	
e1	4.56	BSC	0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.01	1.52	0.040	0.060	
ECN: T16-0236-Rev. P, 16-May-16					

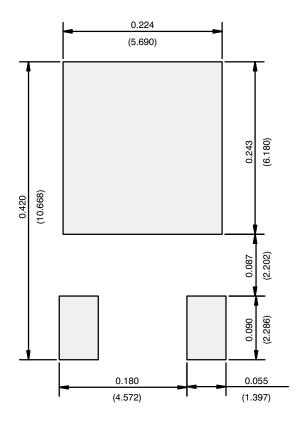
DWG: 5347

#### Notes

• Dimension L3 is for reference only.



### **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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